

TK9A60D

Switching Regulator Applications

• Low drain-source ON-resistance: RDS (ON) = 0.67Ω (typ.)

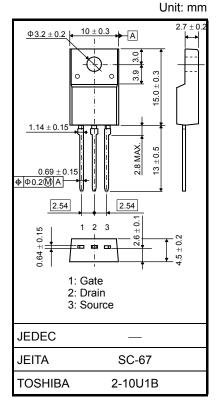
• High forward transfer admittance: $|Y_{fs}| = 4.0 \text{ S (typ.)}$

• Low leakage current: $IDSS = 10 \mu A \text{ (max) (V}_{DS} = 600 \text{ V)}$

• Enhancement mode: $V_{th} = 2.0$ to 4.0 V ($V_{DS} = 10$ V, $I_{D} = 1$ mA)

Absolute Maximum Ratings (Ta = 25°C)

Characteristics			Symbol	Rating	Unit	
Drain-source voltage			V_{DSS}	600	V	
Gate-source voltage			V _{GSS}	±30	V	
Drain current	DC (Note 1)	ΙD	9	Α	
	Pulse (Note 1)	I_{DP}	36		
Drain power dissipation (Tc = 25°C)			P_{D}	45	W	
Single pulse avalanche energy (Note 2)			E _{AS}	260	mJ	
Avalanche current			I _{AR}	9	Α	
Repetitive avalanche energy (Note 3)			E _{AR}	4.5	mJ	
Channel temperature			T _{ch}	150	°C	
Storage temperature range			T _{stg}	-55 to 150	°C	



Weight: 1.7 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Thermal Characteristics

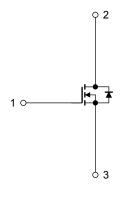
Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	2.78	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	62.5	°C/W

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: $V_{DD} = 90~V,~T_{ch} = 25^{\circ}C (initial),~L = 5.6~mH,~R_G = 25~\Omega,~I_{AR} = 9~A$

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Handle with care.



Electrical Characteristics (Ta = 25°C)

Chara	acteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	$V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±1	μΑ
Drain cut-off current		I _{DSS}	V _{DS} = 600 V, V _{GS} = 0 V	_	_	10	μΑ
Drain-source brea	Orain-source breakdown voltage		I _D = 10 mA, V _{GS} = 0 V	600	_		V
Gate threshold vo	ltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	2.0	_	4.0	V
Drain-source ON	resistance	R _{DS} (ON)	V _{GS} = 10 V, I _D = 4.5 A	_	0.67	0.83	Ω
Forward transfer admittance		Y _{fs}	V _{DS} = 10 V, I _D = 4.5 A	1.0	4.0	_	S
Input capacitance		C _{iss}		_	1200	_	pF
Reverse transfer capacitance		C _{rss}	V _{DS} = 25 V, V _{GS} = 0 V, f = 1 MHz	_	6	_	
Output capacitance		Coss		_	120	_	
Switching time	Rise time	t _r	$\begin{array}{c c} 10 \text{ V} & \text{ID} = 4.5 \text{ A} & \text{VouT} \\ \hline V_{GS} & \text{OV} & \text{OV} & \text{OV} \end{array}$ $\begin{array}{c c} \text{ID} = 4.5 \text{ A} & \text{VouT} \\ \hline V_{DD} \approx 200 \text{ V} \end{array}$	_	25	_	- ns
	Turn-on time	t _{on}		_	60	_	
	Fall time	t _f		_	12	_	
	Turn-off time	t _{off}	Duty ≤ 1%, t _W = 10 μs	_	100	_	
Total gate charge		Qg		_	24	_	
Gate-source charge		Q _{gs}	$V_{DD} \approx 400 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 9 \text{ A}$	_	16	_	nC
Gate-drain charge		Q _{gd}		_	8	_	

Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I_{DR}	_	_	_	9	Α
Pulse drain reverse current (Note 1)	I _{DRP}	_			36	Α
Forward voltage (diode)	V_{DSF}	I _{DR} = 9 A, V _{GS} = 0 V			-1.7	V
Reverse recovery time	t _{rr}	I _{DR} = 9 A, V _{GS} = 0 V,		1300	_	ns
Reverse recovery charge	Qrr	dl _{DR} /dt = 100 A/μs		12		μС

Marking

